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INTERNATIONAL STANDARD

CONSOLIDATED VERSION

Semiconductor devices - iTeh Standards
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IEC Secretariat
3, rue de Varembé
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

Semiconductor devices -

Part 5-13: Optoelectronic devices - Hydrogen sulphide corrosion test for LED packages

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IEC 60747-5-13 edition 1.1 contains the first edition (2021-06) [documents 47E/746/FDIS and 47E/751/RVD] and its amendment 1 (2026-01) [documents 47E/853/CDV and 47E/866/RVC].

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication.

IEC 60747-5-13 has been prepared by subcommittee 47E: Discrete semiconductor devices, of IEC technical committee 47: Semiconductor devices. It is an International Standard.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
47E/746/FDIS	47E/751/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

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